High Energy Density Physics (HEDP) Capabilities at the Linac Coherent Light Source (LCLS)

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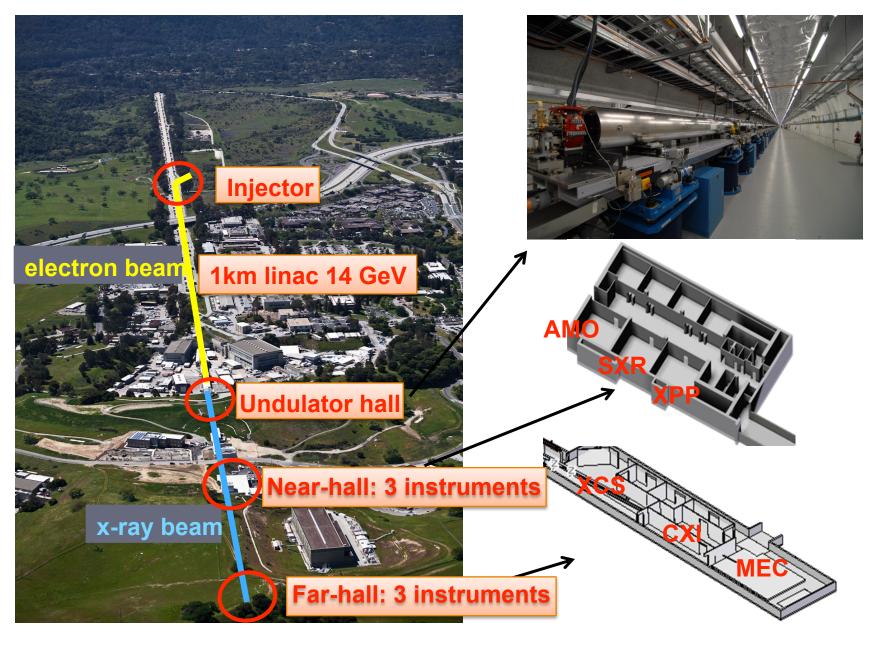


Outline



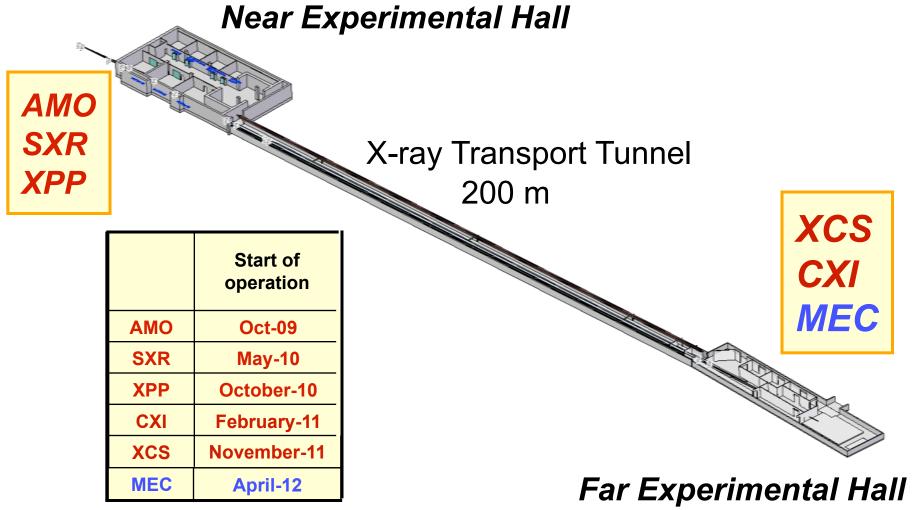
- An introduction to the LCLS Free Electron Laser facility.
- The capabilities of the LCLS MEC instrument.
- Summary

Linac Coherent Light Source (LCLS)



Experimental Halls and Operations Schedules

SLAC



AMO: Atomic, Molecular and Optical

SXR: Soft X-Ray materials sciences

XPP: X-ray Pump-Probe

XCS: X-ray Correlation Spectroscopy

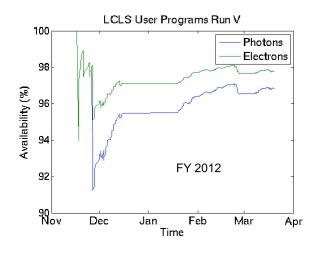
CXI: Coherent X-ray Imaging

MEC: Materials under Extreme Conditions

LCLS Machine Performance

CI	46
JL	

	Baseline performance	Current performance
Photon energy range	830 to 8300 eV	480 to 10,000 eV
FEL pulse length	230 fs	5 - 500 fs
FEL pulse energy	up to 2 mJ	up to 4 mJ



95% photon availability

LCLS produces x-rays with high peak intensity (photons/fs).



X-rays either (i) Make HED matter or (ii) Probe HED states prepared by optical lasers.

LCLS Proposal Process



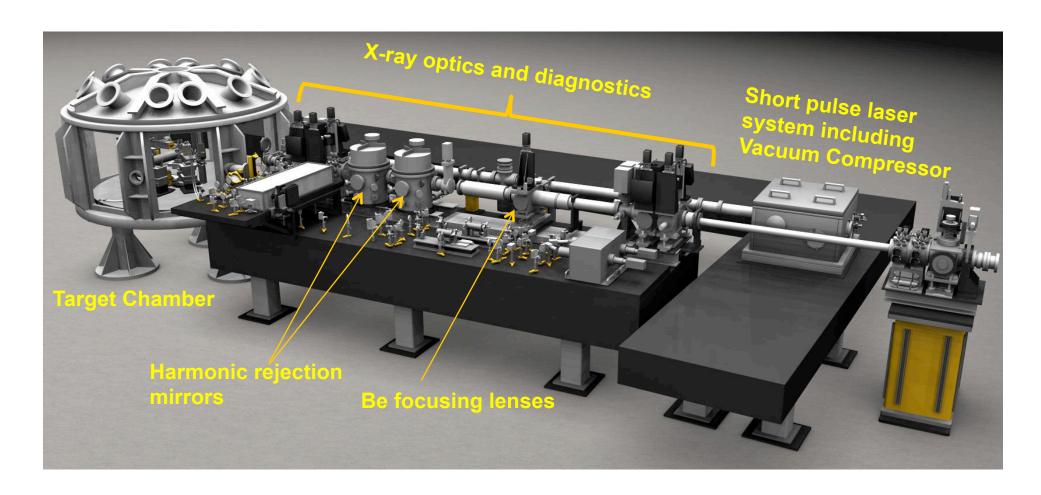
- Proposal deadlines ~ every 6 months, last January 15
- Format: experimental team, scientific case, experimental procedure.
- Proposal Review Panel: includes a High Energy Density Science subpanel.
- ~ 25 % of proposals receive beamtime.
- Independent process for LCLS instrument scientists to submit proposals for a fraction of the beamtime.

LCLS Run 7 Schedule



Jan 13	1	2	3	4	5 Sat	6	7	8	9	10	11	12 Sat	13	14	15 Tue	16 Wad	17 Thu	18	19 Set	20	21	22 Tue	23 Wed	24	25	26 Sat	27	28	29 Tue	30 Wad	31 Thu
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LCLS Materials under Extreme Conditions (MEC) Instrument



- MEC commissioning began at the end of January 2012.
- First user experiment at MEC April 2012 (very aggressive).

MEC Instrument Team

SLAC



Phil Heimann Department Lead



Hae Ja Lee Instrument Scientist



Bob Nagler Instrument Scientist



Eric Galtier Research Associate



Marc Welch Laser Engineer



Brice Arnold Instrument Engineer



Jing Yin Controls,DAQ Engineer

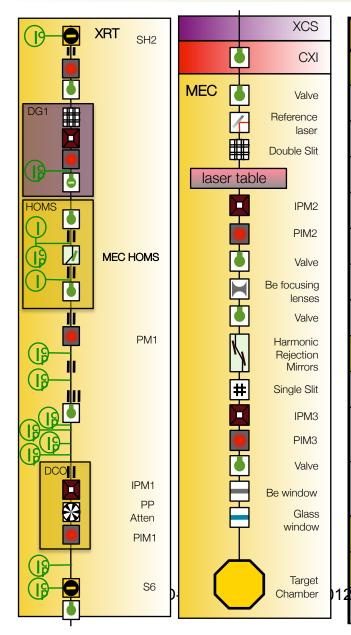


Ruben Curiel Area Manager

- Telephone meetings take place regularly before the beamtimes.
- MEC is responsible for a large fraction of the experimental setup, which changes significantly for each beamtime.
- There is a minimum of 1 week setup time before the beamtime.
- At least 1 instrument scientist or research associate is present throughout the beamtime.
 - Necessary because of the short beamtimes: 5 shifts of 12 hours.

MEC X-ray Optics and Diagnostics

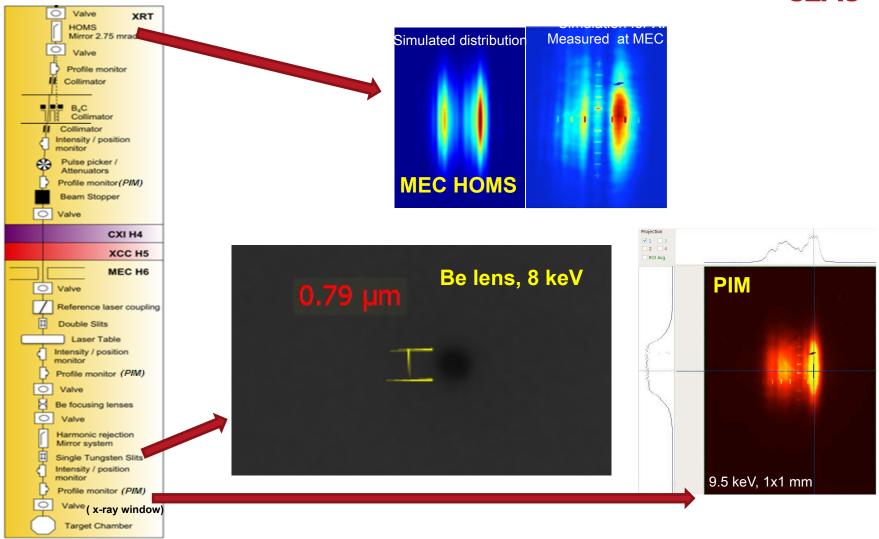
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Requirement	Device			
Steer the beam to MEC	MEC HOMS mirror			
Monitor the beam steering to MEC	Profile Monitor (PM)			
Characterize X-ray pulse intensity	Intensity Position Monitor (IPM)			
Characterize X-ray spatial profile	Profile Intensity Monitor (PIM)			
Tailor X-ray intensity and spectrum	Attenuators			
Tailor X-ray repetition rate	Pulse Picker			
Offline Alignment	Reference Laser			
Tailor X-ray spatial profile (> 50 μm)	Slit system			
Tailor X-ray spatial profile (1~ 50 μm)	Be Focusing Lenses			
Tailor X-ray spectrum	Harmonic Rejection Mirrors			
Allow X-ray beam into target chamber	Be window			
Allow reference optical laser into target chamber	Glass window			
Provide environment for experiment	Target chamber			
Create high pressure or WDM status	MEC Laser Systems			
Measure the spectrum and phase	Target Diagnostics 11			

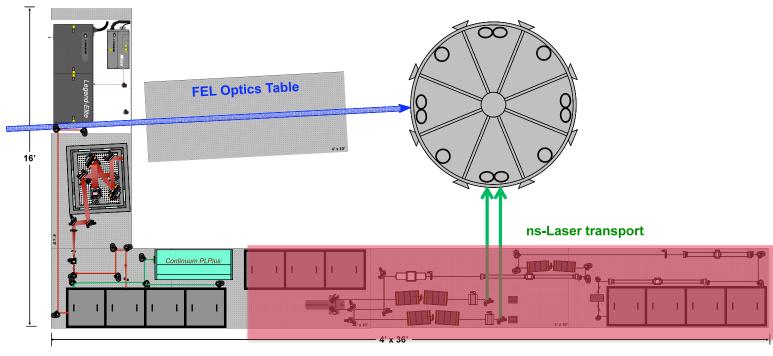
MEC X-ray Commissioning





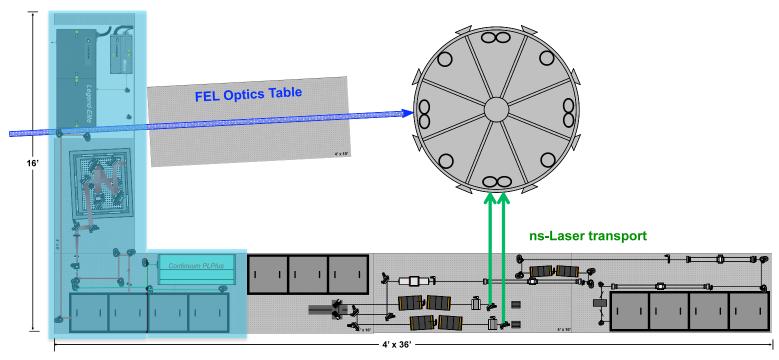
- MEC is a hard x-ray instrument: 2–10 keV photon energy.
- Soft x-ray HEDP experiments have be done at the AMO and SXR instruments.

Generates high pressure states



Long Pulse Laser					
Wavelength	527 nm				
Pulse Width	2-200 ns				
Repetition Rate	1 shot per 10 minutes				
Pulse Energy	2 x 15 Joules				

Heating at constant density



Short Pulse Laser					
Wavelength	800 nm				
Pulse Width	35 fs				
Repetition Rate	10 Hz				
Pulse Energy	120 mJ				

MEC Target Diagnostics: VISAR, FDI

SLAC

Velocity Interferometer System for Any Reflector (VISAR)



Fourier Domain Interferometer (FDI)



Item	Purpose	Specification
VISAR	Measure shock velocity	Nanosecond time scale 5x10 ⁴ ~ 5x10 ⁶ cm/s
Fourier Domain Interferometer (FDI)	Measure surface motion	Accurate to λ/100 for 800 nm probe

MEC Target Diagnostics: XRTS, XUV

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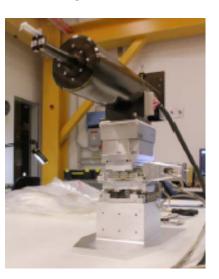
Forward Scattering X-ray spectrometer



Backward Scattering X-ray spectrometer



XUV spectrometer

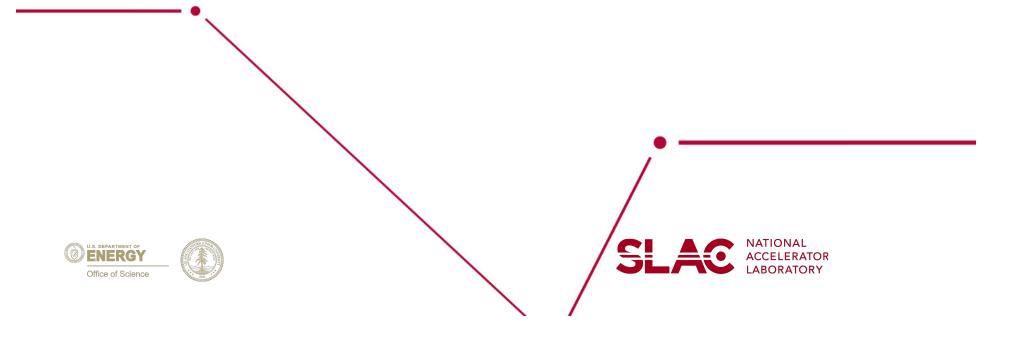


Item	Purpose	Specification					
X-ray Scattering Spectrometer (XRTS)	Measure electron density and temperature Forward XRTS: automatic change of scattering angle, 0°< θs <90°	Spectral resolution of ∆E/E~4×10 ⁻³ at 8 keV temperature (1 ~ 100 eV)					
XUV spectroscopy	Measure electron temperature and study electronic band structures	Spectral resolving power of $\lambda/\Delta\lambda \sim 300$ at 21 nm temperature (0.1 ~ 50 eV)					

Summary

- The LCLS is the first hard x-ray FEL.
 - It began operations in 2009.
- LCLS MEC instrument has been in operation since April 2012.
 - X-ray optics and diagnostics
 - Long and short pulse laser systems
 - Target diagnostics
- HEDP experiments at LCLS (Bob Nagler tomorrow).

End of Presentation



LCLS Collaborations

SLAC

- Soft x-ray self-seeding
 - LBNL: Mechanical engineering
 - PSI: X-ray optics
- LCLS-II
 - LBNL: Undulators